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UTILITY PATENT APPLICATION TRANSMITTAL	Attorney Docket No. ONX-110	Total Pages
	First Named Inventor BEHRANG BEHIN	
	Title CAPACITIVE SENSING SCHEME FOR DIGITAL CONTROL STATE DETECTION IN OPTICAL SWITCHES	

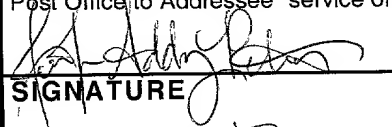
APPLICATION ELEMENTS	ACCOMPANYING APPLICATION PARTS
1. <input type="checkbox"/> Fee Transmittal Form	8. <input type="checkbox"/> Assignment cover sheet and document(s)
2. <input checked="" type="checkbox"/> Specification Total Pages: [21]	9. <input type="checkbox"/> Power of Attorney by Assignee [] with CFR 3.73(b) statement
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a. <input type="checkbox"/> Newly executed (original or copy)	12. <input type="checkbox"/> Preliminary Amendment
b. <input type="checkbox"/> Copy from a prior application 1.63(d) (complete Box 17 and note Box 5 below)	13. <input checked="" type="checkbox"/> Return Receipt Postcard (MPEP 503)
i. <input type="checkbox"/> Signed statement deleting inventors named in the prior application, see CFR 1.63(d)(2) and 1.33(b)	14. <input type="checkbox"/> Small Entity Statement [] Statement filed in prior application Status still proper and desired
5. <input type="checkbox"/> Incorporation by Reference (if 4b is checked) The entire disclosure of the prior application, from which a copy of the oath or declaration is supplied under Box 4b, is considered as being part of the disclosure of the accompanying application and is hereby incorporated therein by reference.	15. <input type="checkbox"/> Certified Copy of Priority Document(s) (if foreign priority is claimed)
6. <input type="checkbox"/> Microfiche Computer Program (<i>Appendix</i>)	16. <input type="checkbox"/> Other:
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VERIFIED STATEMENT (DECLARATION) CLAIMING SMALL ENTITY STATUS (37 CFR 1.9(f) and 1.27(d)) – SMALL BUSINESS CONCERN

Application No.: Not assigned
 Filing Date: Filed herewith
 Applicant(s): Behrang Behin et al.
 Title: Capacitive Sensing Scheme for Digital Control State Detection in Optical Switches

I hereby declare that I am the owner of, or an official empowered to act on behalf of, the entity identified below:

Name of Concern: Onix Microsystems, Inc.

Address of Concern: 4138 Lakeside Drive
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I hereby declare that the concern identified above qualifies as a small business concern as defined in 37 CFR 1.9(d), for purposes of paying reduced fees to the United States Patent and Trademark Office under section 41(a) and (b) of Title 35, United States Code, in that the number of employees of the concern, including those of its affiliates, does not exceed 500 persons. For purposes of this statement, (1) the number of employees of the business concern is the average over the previous fiscal year of the concern of the persons employed on a full-time, part-time or temporary basis during each of the pay periods of the fiscal year, and (2) concerns are affiliates of each other when either, directly or indirectly, one concern controls or has the power to control the other, or a third party or parties controls or has the power to control both.

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I acknowledge the duty to file, in this application for patent, notification of any change in status resulting in loss of entitlement to small entity status prior to paying, or at the time of paying, the earliest of the issue fee or any maintenance fee due after the date on which status as a small entity is no longer appropriate (37 CFR 1.28(b)).

I hereby declare that all statements made herein of my own knowledge are true and that all statements made on information and belief are believed to be true; and further that these statements were made with the knowledge that willful false statements and the like so made are punishable by fine or imprisonment, or both, under section 1001 of Title 18 of the United States Code, and that such willful false statements may jeopardize the validity of the application, any patent issuing thereon, or any patent to which this verified statement is directed.

ASSIGNEE: Onix Microsystems, Inc.
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 Date

PATENT APPLICATION

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TITLE OF INVENTION

Capacitive Sensing Scheme for Digital Control State Detection in
Optical Switches

10

INVENTORS

Behrang Behin, Michael J. Daneman, Meng H. Kiang, Kam Y. Lau,
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FIELD OF THE INVENTION

This invention relates generally to microelectromechanical
systems (MEMS). More particularly, it relates to sensing a
control state of MEMS devices.

20

CROSS REFERENCE TO RELATED APPLICATION

This application is based on Provisional application 60/196,055,
filed April 10, 2000, which is herein incorporated by reference.

25

BACKGROUND ART

Previous patents and publications have described fiber-optic
switches that employ moveable micromirrors that move between two
positions. An example is shown in Fig. 1. Some of the prior
art also employs electrostatic clamping of these mirrors at one
or more of its two positions. For example, optical crossbar
switches consisting of a series of moveable mirrors that are

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magnetically actuated are known in the art. The mirrors can be electrostatically clamped either in the horizontal position to the substrate or in the vertical position to the sidewalls of a separate chip. In the vertical position, the mirrors deflect
5 light from an input fiber into an output fiber.

Previous work has described optical switches that use mirrors that are actuated between several discrete positions for switching light. These optical switches may rely on
10 electrostatic comb drives to rotate the mirror. An electrostatic comb drive uses electrostatic forces between interdigitated fixed and movable comb members to rotate a device such as a mirror. It is possible to determine the relative angular position of the movable comb drive member with respect
15 to the fixed comb drive member by measuring the capacitance between them. Unfortunately, comb drives have a limited range of angular movement and the capacitance may change only slightly over a desired range of discrete positions of the mirror. If each discrete position represents a different control state of an optical switch, it is difficult to correlate the capacitance
20 measurement from the comb drive to the control state of the switch. Furthermore, not all optical switches use comb drive actuators.

Some of the prior art approaches require electrostatic clamping of a mirror structure to various electrodes in its different positions. For example, Behin et al. describe an optical crossbar switch consisting of a series of moveable mirrors that are magnetically actuated and can be electrostatically clamped
25 either in the horizontal position to the substrate or in the vertical position to the sidewalls of a separate chip. Fujita et al. describe similar micromirrors that are electrostatically clamped against a shallow stop when deflected vertically.
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Fig. 1 depicts an optical crossbar switch **100** that contains mirrors **102** that rotate between horizontal and vertical positions in order to switch optical signals **104** between one or more input fibers **106** and one or more output fibers **108**. The mirrors **102** are typically rotated by a combination of magnetic force and mechanical torsion in a hinge member (not shown) at the axis of rotation of the mirror. Optical switches like that shown in Fig. 1 are described in detail in U.S. Patent No. 4,580,873, entitled "Optical Matrix Switch," Issued April 8, 1986 to Frank H. Levinson, which is incorporated herein by reference. Comb drives are generally not used to actuate this type of switch because it is difficult to create a comb drive that could directly move the mirror over the desired angular range without some additional mechanical linkage. One means for fault detection in optical switches involves monitoring of the optical signals received by the output fibers **108**. A splitter incorporated into the switch or fiber taps at the output fibers **108** can be used to monitor the output signals. This prior art method may also require monitoring of the input signal, since the criteria for failure is often a discrepancy between the input and the output signals. Unfortunately, monitoring the input and output optical signals incurs additional optical losses to the switch **100** since it requires tapping optical energy from the signals for monitoring. Furthermore, monitoring the input and output signals does not specifically indicate the cause of the failure, as the mirror position is not directly monitored.

There is a need, therefore, for an improved MEMS device with improved fault detection to directly detect faults in the control state of the mirror positioning mechanism.

OBJECTS AND ADVANTAGES

Accordingly, it is a primary object of the present invention to provide microelectromechanical system (MEMS) device having a fault detection system that directly measures mirror control state.

SUMMARY

The objects and advantages are attained by an apparatus and method that allow for detection of whether a rotatable MEMS element is in a first or second position, , e.g., horizontal or vertical, and whether it is properly clamped in either of these two positions. This sensing capability is useful for fault detection. By sensing the mirror position, mirror failure can be immediately detected, and traffic through the switch can be appropriately re-routed.

Embodiments of the invention provide apparatus and methods for detecting whether mirrors used in a certain type of optical switch are in the "on" or "off" position. Specifically, this invention applies to switches that employ mirrors that move between an "on" or "off" position, wherein they reflect light from an input fiber into an output fiber in the "on" position, and allow the light to pass in the "off" position. Electrodes are positioned in this system such that the mirrors are close to, and therefor capacitively coupled to, a different electrode depending on whether they are in the "on" or "off" position. This invention is especially useful for switches that already employ electrodes for electrostatic clamping of mirrors in one or more positions, since those same electrodes can be used both to electrostatically clamp the mirrors and to sense their position. The method described in this invention comprises sensing of the capacitance between the mirrors and the one or more electrodes used to clamp the mirrors in its one or more positions in order to detect which of the positions the mirrors are clamped in. Furthermore, the magnitude of the capacitances

can be monitored to detect improper clamping. The apparatus may be incorporated into a MEMS mirror optical switch controlled by a computer processor.

BRIEF DESCRIPTION OF THE FIGURES

Fig. 1 depicts a crossbar configuration for a MEMS optical switch according to the prior art;

Fig. 2A-2B depict simplified schematic diagrams of a MEMS device according to an embodiment of the present invention; and

Fig. 3 depicts a simplified block diagram of an MEMS apparatus according to an embodiment of the present invention;

Fig. 4A depicts simplified cross sectional schematics of the apparatus of Fig. 3 in three different positions;

Figs. 4B-4C depict capacitance values corresponding to the three positions depicted in Fig. 4A;

Fig. 5 depicts a simplified timing diagram for operation of a MEMS device according to an embodiment of the present invention; and

Fig. 6 depicts a block diagram depicting an optical communications system according to an additional embodiment of the invention.

DETAILED DESCRIPTION

Although the following detailed description contains many specifics for the purposes of illustration, anyone of ordinary skill in the art will appreciate that many variations and alterations to the following details are within the scope of the invention. Accordingly, the following preferred embodiment of the invention is set forth without any loss of generality to, and without imposing limitations upon, the claimed invention.

Figs. 2A-2B depict an apparatus 200 according to an embodiment of the invention. The apparatus generally comprises a rotatable element 202, and first and second electrodes 204, 206. The first

electrode **204** is typically located adjacent to the element **202** when element **202** is in its vertical position. The second electrode **206** is typically located adjacent to the element **202** when element **202** is in its horizontal position. For the purpose of example, and without loss of generality, the rotatable element **202** may be a MEMS mirror that rotates about a substantially horizontal axis **201** relative to a static part **203**. The rotatable element may include a separate electrode for clamping or capacitance sensing. Alternatively, if the rotatable element **202** is electrically conductive, the element **202** itself may be regarded as an electrode. In the exemplary embodiment depicted in Figs **2A-2B** the rotatable element **202** rotates between two positions that are substantially 90° apart. In particular, the rotatable element rotates between a vertical position, as shown in Fig. **2A**, and a horizontal position, as shown in Fig. **2B**. The vertical position defines a first or "on" control state. The horizontal position defines a second or "off" control state. In the embodiments of the present invention the capacitance between the rotatable element **202** and the electrodes **204,206** depends on whether the rotatable element is in the first or second position.

The first electrode **204** can be placed so that it is disposed close to and substantially parallel with the rotatable element **202** in the vertical position. The capacitance between the rotatable element **202** and the first electrode **206** can be monitored to determine the control state of the rotatable element **202**. For example when the rotatable element **202** is flipped to the vertical position from the horizontal position, the capacitance between the element **202** and the first electrode **204** changes from a low value to a much higher value. At the same time, the capacitance between the rotatable element **202** and the second electrode **206** changes from a high value to a lower value. In a similar fashion, the capacitance between the second

electrode **206** and the rotatable element **202** can be used to detect the control state of the when it is in the horizontal position. The magnitude of the "on"-state capacitance is known, and if the element **202** is somehow improperly positioned in the "on" state, the capacitance may not reach the known value, and a fault may be indicated.

In the device **200**, the electrodes **204**, **206** may also serve as clamping electrodes as well as for capacitive control state sensing. Alternatively, the device **200** may include separate electrodes for sensing and clamping. In the case of an array of rotatable elements, e.g., MEMS mirrors, the electrodes for the "off", or horizontal, state detection may be electrically shorted to each other. In such a case, the static part **203** may comprise a substrate to which the mirrors are mounted. Similarly, the "on", or vertical, state electrodes may comprise a single component with features that define a vertical electrode for each mirror.

Fig. **3** depicts a simplified cross-sectional schematic diagram of an apparatus **300** according to an embodiment of the present invention. The apparatus generally comprises a MEMS device **310**, and a device controller **320**. The device **310** typically includes a substrate **311** and a rotatable element **312**, such as a mirror. The substrate **311** includes a vertical stop **315** and a horizontal stop **317**. The rotatable element **312** rotates about an axis oriented substantially parallel to a plane of the substrate **311**. The rotatable element **312** may be attached to the substrate **311** by a torsional flexure **313**. The rotatable element **312** rotates, e.g. under magnetic actuation, between a vertical position proximate the vertical stop **315** and a horizontal position proximate the horizontal stop **317**. The substrate **311** further includes vertical and horizontal electrodes **314**, **316** proximate the vertical and horizontal stops **315**, **317**. The electrodes **314**,

316 are typically electrically isolated from each other and from the rotatable element 312. The controller 320 typically includes a processor 321, a fault detector 322, a state selector 323, vertical and horizontal capacitance sensors 324, 326 and vertical and horizontal power voltage sources 327, 329. The state selector 323 and fault detector 322 are coupled to the processor 321. The capacitance sensors 324, 326, are coupled to the electrodes 314, 316 respectively and to the fault detector 322. Conditioning electronics 325V, 325H, such as amplifiers or analog to digital (A/D) converters, may optionally be coupled between the capacitance sensors 324, 326 and the fault detector 322. In the embodiment shown in Fig. 3, the voltage sources 327, 329 are coupled to the electrodes 314, 316 respectively. The voltage sources 327, 329 supply clamping voltages to the electrodes 314, 316 to clamp the rotatable element to the vertical stop 315 or the horizontal stop 317. Alternatively, the device 310 may include separate clamping electrodes coupled to the voltage sources 327, 329.

For example, it is often the case that the capacitance sensors are coupled to conditioning electronics that interpret the signals from the capacitance sensors. Such conditioning electronics may include amplifiers, analog-to-digital converters, and the like. It is often desirable to ensure that the conditioning electronics receive signals from the sensors having an acceptable level of noise. The acceptable value of the noise level depends on the circuit and the required precision in the specific application. For very small capacitance signals, e.g., of order 10^{-15} farads, this may affect the design of the apparatus.

For example, to reduce the signal to noise ratio, it may be important that the conditioning electronics be located in close proximity to the capacitive sensors. A short distance between

the sensors and the electronics reduces the amount of wiring between them, thereby reducing noise. Close proximity between the sensor and the electronics may be ensured by placing the conditioning electronics in the same packaging as the sensor, e.g., on a die adjacent to a die containing a MEMS device with the sensors. The sensors and conditioning electronics may be connected by wire bonding across the die. Alternatively, the conditioning electronics may be integrated into the same die as the MEMS die itself.

Although only a single device **310** with a rotatable element **312** is shown in Fig. **3**, those of skill in the art will recognize that the device **310** may include an array containing any number of such devices. Furthermore, the inventive concepts described herein may also be applied to micromirror architectures such as those described in H. Toshiyoshi and H. Fujita, "Electrostatic micro torsion mirrors for an optical switch matrix," *J. Microelectromech. Syst.*, vol. 5, no. 4, 231-7, Dec. 1996. and E. L. Goldstein, and R. W. Tkach, "Free-space micromachined optical switches with sub-millisecond switching time for large-scale optical crossconnects," *OFC'98 and IEEE Photonics Technol. Lett.*, April 1998, both of which are incorporated herein by reference.

The relationship between the position of the rotatable element **312** and the capacitance values measured by the sensors **314**, **316** is illustrated in Figs. **4A-4C**. When the rotatable element is in the vertical state, as shown on the left in Fig. **4A**, a large capacitance is detected between the rotatable element **312** and the vertical electrode **314**, and a small capacitance is detected between the rotatable element **312** and the horizontal electrode **316** as shown on the left of Figs. **4B** and **4C**. This combination of capacitances indicates that the rotatable element **312** is in an "up" digital control state. When the rotatable element **312**

is switching and is in between the vertical position and the horizontal position (or vice versa), as shown in the middle in Fig. 4A, a small capacitance is detected between the rotatable element 312 and both the horizontal electrode 316 and the vertical electrode 314 as shown in the middle of Figs. 4B and 4C. When the rotatable element 312 is in the horizontal position, as shown on the right in Fig. 4A, a large capacitance is detected between the rotatable element 312 and the horizontal electrode 316, and a small capacitance is detected between the rotatable element 312 and the vertical electrode 314 as shown on the right of Figs. 4B and 4C. This combination of capacitances indicates that the rotatable element 312 is in a "down" digital control state. The capacitance can be measured across the same electrical connections that are used to supply the electrostatic clamping voltages from the voltage sources 327, 327 and the electrodes 314, 316.

The processor 321 determines the appropriate control state for the rotatable element 312 and supplies a control signal to the state selector 323 and the fault detector 322. The state selector 323 determines which voltage source 327, 329 applies a clamping voltage based on a control signal from the processor. Those of skill in the art will recognize that the state selector 323 may be implemented in either hardware, software or a combination of both. Although two voltage sources 327, 329, are depicted in Fig. 3, the control state selector may alternatively be connected to a single voltage source, which is selectively coupled to the electrodes 314, 316 by a switch. The fault detector 322 compares the control signal from the processor to a measured control state determined by measurements from the capacitance sensors 324, 326. In either the horizontal or vertical position, the sensors 324, 326 can detect exact magnitude of the capacitance to indicate improper clamping of the rotatable element 312. For example, if a particle (e.g. a

5 piece of dust) lands on one of the clamping surfaces and causes the mirror to clamp at an improper angle to the vertical sidewall, the capacitance detected between the rotatable element **312** and the vertical electrode **314** will be different than that normally detected in the vertical control state. In such a situation the fault detector **322** would signal a fault to the processor **321**. Those of skill in the art will recognize that the fault detector **322** may be implemented in either hardware, software or a combination of both.

10 The apparatus **300** may operate according to a method according to an embodiment of the present invention. The method **500** is set forth in the flow diagram of Fig. **5**. In the method **500** begins at step **502** with the provision of an apparatus with a rotatable element and such as the apparatus **300**. Electrodes, such as the vertical and horizontal electrodes **314**, **316** are provided at step **504**. At step **506** a capacitance between the rotatable element and one or more of the electrodes is measured, e.g. with sensors such as the sensors **324**, **326**. In the apparatus **300**, the capacitance sensors **324**, **326** measure the capacitance between the rotatable element **312** and the electrodes **314**, **316** to monitor the control state of the rotatable element **312**. Various methods exist for detecting the capacitance between the rotatable element **312** and the electrodes **314**, **316**. For example, in step **506**, a small AC signal may be superimposed on top of a DC signal that is supplied by one or more of the voltage sources **327**, **329** for electrostatic clamping. The sensors **314**, **316** can monitor a current arising from this small AC signal to indicate the capacitance. An alternative method employs time-division multiplexing of actuation and sense signals. In this scheme, the DC actuation signal is periodically turned off and replaced by a small AC or DC sense signal. The sensors **314**, **316** measure the sense signal to monitor the capacitance. Preferably, the

time-multiplexing is done at a rate much faster than the natural frequency of the device .

5 The capacitance signals from the sensors **314**, **316** can be used to properly time the electrostatic clamping signals used for clamping the rotatable element **312** in its two positions. For example, when the rotatable element **312** is actuated up to a position near the vertical stop **315**, the processor signals the state selector to apply a voltage to the vertical electrode **314**
10 to pull the rotatable element **312** in to the vertical stop **315** and clamp it there electrostatically. After the rotatable element **312** is pulled in, the voltage can be reduced to a lower value, since a lower voltage is needed to hold the rotatable element **312** next to the electrode **314** than that needed to pull it in. Monitoring of the capacitance signal can allow proper timing of these signals. That is, the clamp voltage would be lowered only when the capacitance value from the vertical capacitance sensor **324** indicates that the rotatable element **312**
15 has reached the vertical position.

20 In the descriptions above, it is assumed that the electrodes used for clamping are also used for sensing. It is also possible to divide the electrode structures into several isolated regions, in which case one set of electrodes can be used for electrostatic clamping or actuation, and another set
25 for capacitive sensing.

FIG. 6 depicts a block diagram depicting an optical communications system **600** according to an additional embodiment
30 of the invention. In the system **600**, a method having features in common with step **506** of method **500** of FIG. **5** is implemented as a computer program code **605** running on a processor of a computer controlled apparatus having features in common with the apparatus **300** described above with respect to FIG. **3**. In the

exemplary embodiment shown, the program code **605** controls the operation of one or more MEMS mirrors **M** in a crossbar optical switch **S**. The switch **S** may have features in common with the type of switch **100** shown in Fig. **1**. One or more input fibers **IF** and output fibers **OF** are coupled to the switch **S**. Each mirror **M** is rotatably coupled to a substrate and actuated by electrostatic or magnetic actuators **A**. The mirrors **M** are clamped in the vertical or horizontal position by voltages applied to clamping electrodes **CE**.

The system **600** includes a controller **601**. The controller **601** includes a programmable central processing unit (CPU) **602** that is operable with a memory **604** (e.g., RAM, DRAM, ROM, and the like) an optional mass storage device, **606** (e.g., CD-ROM hard disk and/or removable storage), and well-known support circuits **610** such as power supplies **612**, clocks **614**, cache **616**, input/output (I/O) circuits **618** and the like. All of the above elements may be coupled to a control system bus **608**.

The memory **604** contains instructions that the processor unit **602** executes to facilitate the performance of the apparatus **600**. The instructions in the memory **604** are in the form of the program code **605**. The program code may conform to any one of a number of different programming languages. For example, the program code can be written in C+, C++, BASIC, Pascal, JAVA or a number of other languages. The mass storage device **606** stores data and instructions and retrieves data and program code instructions from a processor readable storage medium, such as a magnetic disk or magnetic tape. For example, the mass storage device **606** can be a hard disk drive, floppy disk drive, tape drive, or optical disk drive. The mass storage device **606** stores and retrieves the instructions in response to directions that it receives from the processor unit **602**. The processor unit **602** operates the apparatus **600** using data and program code

instructions that are stored and retrieved by the memory **604** and/or the mass storage device **606**. The data and program code instructions may be first retrieved by the mass storage device **606** from a medium and then transferred to the memory **604** for use by the processor unit **602**.

The apparatus **600** may optionally include a user interface **620**, such as a keyboard, mouse, or light pen, coupled to the processor unit **602** to provide for the receipt of inputs from an operator (not shown). The apparatus **600** may also optionally include a display unit **622** to provide information to the operator in the form of graphical displays and/or alphanumeric characters under control of the processor unit **602**.

The control system bus **608** provides for the transfer of data and control signals between all of the devices that are coupled to the control system bus **608**. Although the control system bus **608** is displayed as a single bus that directly connects the devices in the processor unit **602**, the control system bus **608** can also be a collection of busses. For example, the display unit **622**, user interface **620** and mass storage device **606** can be coupled to an input-output peripheral bus **608**, while the processor unit **602** and memory **604** are coupled to a local processor bus. The local processor bus and input-output peripheral bus are coupled together to form the control system bus **608**.

The system controller **601** is coupled to the elements of the apparatus **600**, for turning off a source of optical power in accordance with embodiments of the present invention via the system bus **608** and the I/O circuits **618**. These elements include the following: one or more clamping voltage sources **CV** and capacitance sensors **CS** coupled to clamping electrodes **CE** in the switch **S**, and one or more actuator drivers **AD** coupled to the actuators **A**. For the sake of clarity, connection is shown to

only one of the clamping electrodes **CE** and one of the actuators **A**. In practice, all the clamping electrodes **CE** and actuators **A** could be coupled to the I/O circuits **618**. The system controller **601** provides signals to the above elements to switch optical signals between the input fibers **IF** and the output fibers **OF**.

The steps of the method of the method described above with respect to FIG. **5** could be implemented by a suitable computer program running on the CPU **602** of the controller **601**. The CPU **602** forms a general purpose computer that becomes a specific purpose computer when executing programs such as the program **505** of the embodiment of the method of the present invention depicted in the flow diagram of FIG. 2. Although the invention is described herein as being implemented in software and executed upon a general purpose computer, those skilled in the art will realize that the invention could be implemented using hardware such as an application specific integrated circuit (ASIC), microcontroller or other hardware circuitry. As such, it should be understood that the invention can be implemented, in whole or in part, in software, hardware or both.

Those skilled in the art would be readily able to devise a computer program **605** to implement step **506** described above with respect to FIG. **5**. The program **605** is suitable for monitoring and controlling the switch **S** in accordance with embodiments of the present invention. Although the program **605** is described herein with respect to a MEMS optical switch, those skilled in the art will recognize that programs embodying the method of the present invention can be applied to any MEMS device.

It will be clear to one skilled in the art that the above embodiments may be altered in many ways without departing from the scope of the invention. Accordingly, the scope of the

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invention should be determined by the following claims and their legal equivalents.

CLAIMS

What is claimed is:

1. A microelectromechanical device, comprising
 - a) a rotating element including a first electrode;
 - b) a second electrode;
 - c) means, coupled to the first and second electrodes for measuring a capacitance between them; and
 - d) means coupled to the capacitance sensing means for determining from the capacitance a digital control state of the device.
2. The device of claim 1 further comprising means for determining a deviation from a desired control state.
3. The device of claim 1 wherein the element has two control states.
4. The device of claim 1, further comprising means for rotating the rotatable element.
5. The device of claim 1 wherein the element is a MEMS mirror.
6. A microelectromechanical system (MEMS) apparatus, comprising
 - a) an element configured to rotate between a first angular position and a second angular position;
 - b) one or more electrodes disposed proximate the element, wherein a capacitance between the element and the electrode has a first value when the element is in a first control state and the capacitance has a second value when the element is in a second control state;

- 10 c) means, for measuring a value the capacitance between
 11 the element and the at least one of the one or more
 12 electrodes; and
 13 d) means coupled to the capacitance sensing means for
 14 determining a control state of the element from the
 15 value of the capacitance.

1 7. The device of claim 6 wherein the first and second
 2 angular positions are substantially 90° apart.

1 8. The device of claim 6 further comprising means for
 2 actuating the element.

1 9. The device of claim 6 further comprising means for
 2 electrostatically clamping the element in at least one of
 3 the first and second positions.

1 10. The device of claim 9, wherein the clamping means
 2 comprises a clamping voltage source electrically
 3 coupled to one or more of the one or more
 4 electrodes.

1 11. The device of claim 6, further comprising a substrate,
 2 wherein the element connected to the substrate by a
 3 hinge.

1 12. The device of claim 11, wherein the one or more
 2 electrodes includes an electrode disposed on the
 3 substrate proximate the element.

1 13. The device of claim 11, wherein the substrate
 2 includes a vertical stop disposed proximate the
 3 element.

1 14. The device of claim 13, wherein the one or more
 2 electrodes includes an electrode attached to the
 3 vertical stop.

1 15. The device of claim 6, wherein the element is a MEMS
2 mirror.

1 16. A method for sensing the control state of a
2 microelectromechanical device, comprising:

- 3 a) providing an element that is rotatable relative to a
4 static part between a first control state and a second
5 control state;
6 b) disposing a first electrode and a second electrode
7 proximate element; and
8 c) measuring a value of a capacitance between the element
9 and one or more of the first and second electrodes to
10 determine whether the element is in the first control
11 state, the second control state, or neither the first nor
12 second control state.

1 17. The method of claim 16, further comprising applying an
2 electrostatic clamping voltage to one or more of the
3 first and second electrodes.

1 18. The method of claim 17, wherein the clamping
2 voltage is a DC voltage and c) includes
3 superimposing an AC signal on the clamping
4 voltage.

1 19. The method of claim 17, wherein the clamping
2 voltage and a sensing signal are alternately
3 applied in time.

1 20. The method of claim 16 further comprising determining
2 the presence of a fault in the microelectromechanical
3 device from the value of the capacitance.

1 21. The method of claim 16 further comprising using the
2 value of the capacitance to time the actuation of the
3 element.

- 1 22. An optical communications system, comprising:
- 2 a) one or more input optical fibers;
- 3 b) one or more output optical fibers;
- 4 c) a microelectromechanical system (MEMS) optical
- 5 switch including:
- 6 i) one or more MEMS mirrors configured to
- 7 rotate between a first angular position and
- 8 a second angular position;
- 9 ii) one or more electrodes disposed proximate
- 10 each of the one or more mirrors, wherein a
- 11 capacitance between the mirrors and the
- 12 electrodes has a first value when the
- 13 mirrors are in a first control state and the
- 14 capacitance has a second value when the
- 15 element is in a second control state;
- 16 iii) means, for measuring a value the capacitance
- 17 between at least one of the one or more
- 18 mirrors and the at least one of the one or
- 19 more electrodes; and
- 20 iv) means coupled to the capacitance sensing
- 21 means for determining a control state of the
- 22 element from the value of the capacitance.

ABSTRACT OF THE DISCLOSURE**CAPACITIVE SENSING SCHEME FOR DIGITAL CONTROL STATE
DETECTION IN OPTICAL SWITCHES**

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Disclosed is an apparatus and method for detecting whether rotatable MEMS elements are in the "on" or "off" position. Embodiments of the invention have application in devices switches that employ mirrors that move between an "on" or "off" position, wherein they reflect light from an input fiber into an output fiber in the "on" position, and allow the light to pass in the "off" position. Electrodes are positioned in the device such that the mirrors are close to, and therefor capacitively coupled to, a different electrode depending on whether they are in the "on" or "off" position. This invention is especially useful for switches that already employ electrodes for electrostatic clamping of mirrors in one or more positions, since those same electrodes can be used both to electrostatically clamp the mirrors and to sense their position. The method described in this invention comprises sensing of the capacitance between the mirrors and the one or more electrodes used to clamp the mirrors in its one or more positions in order to detect which of the positions the mirrors are clamped in. Furthermore, the magnitude of the capacitances can be monitored to detect improper clamping.

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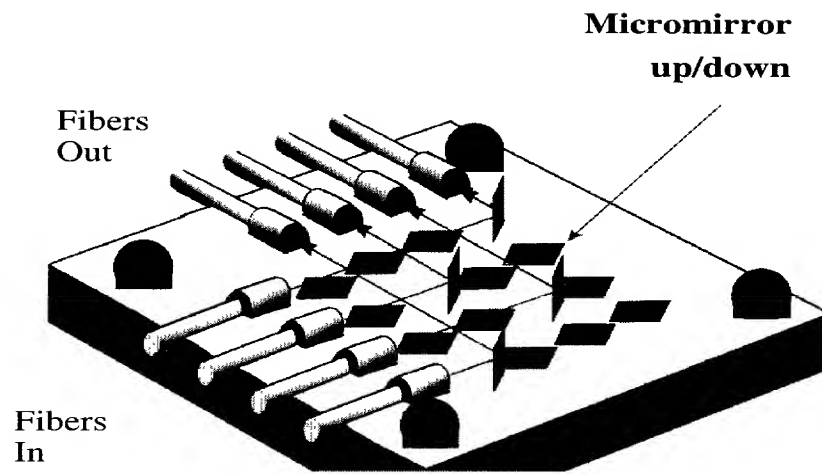
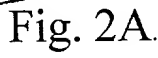
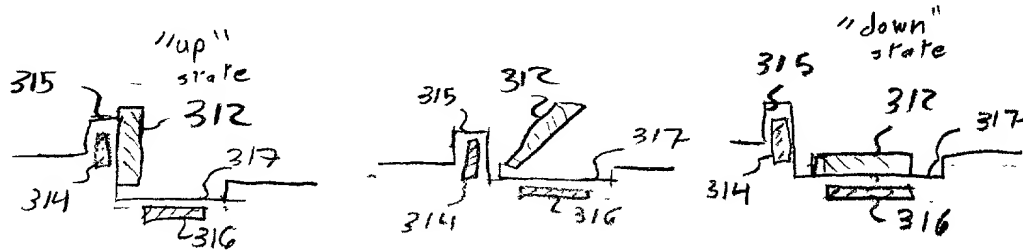
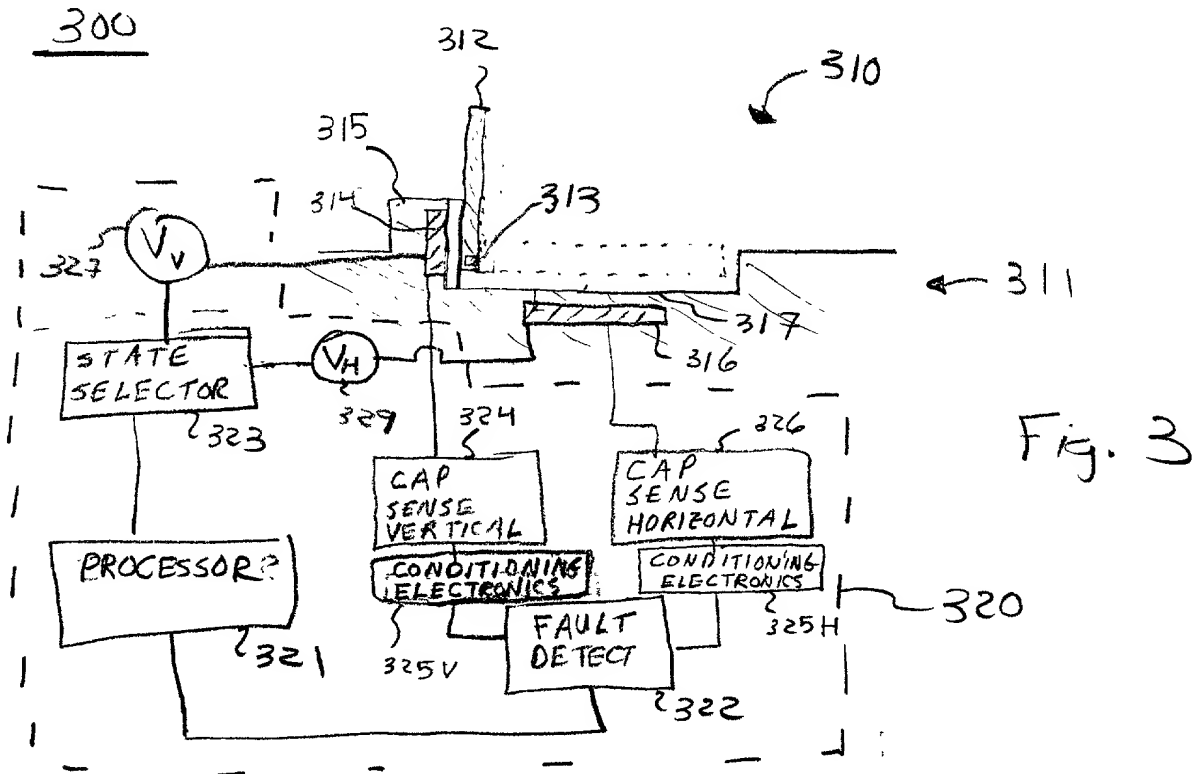
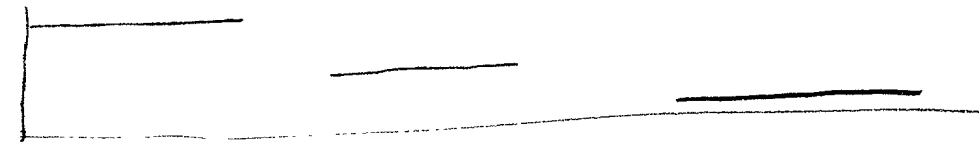


Fig. 1
(Prior Art)

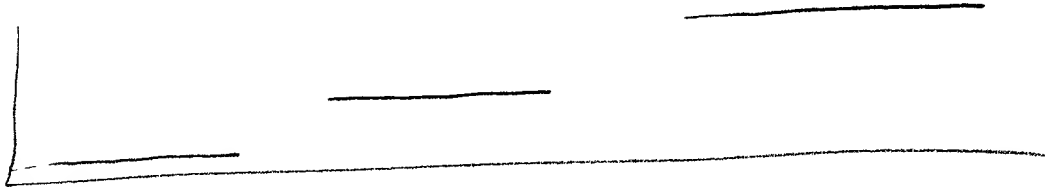




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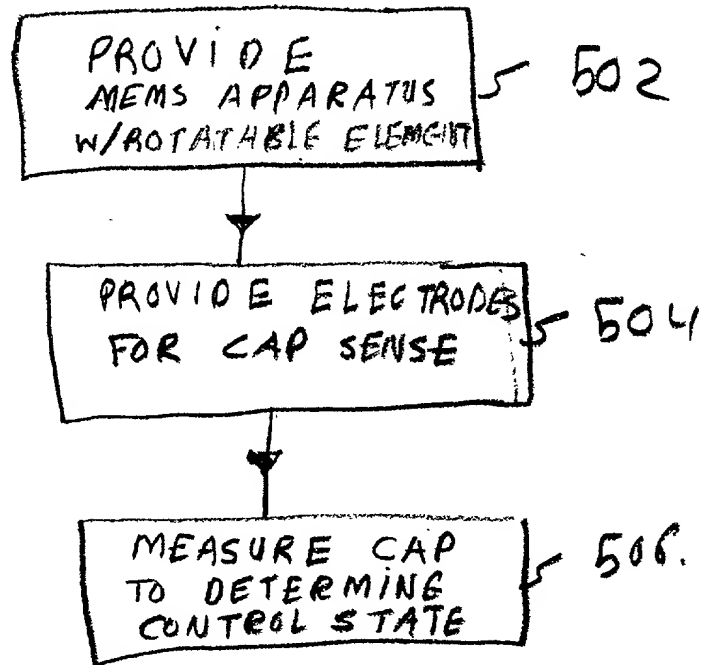
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Fig. 5

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600

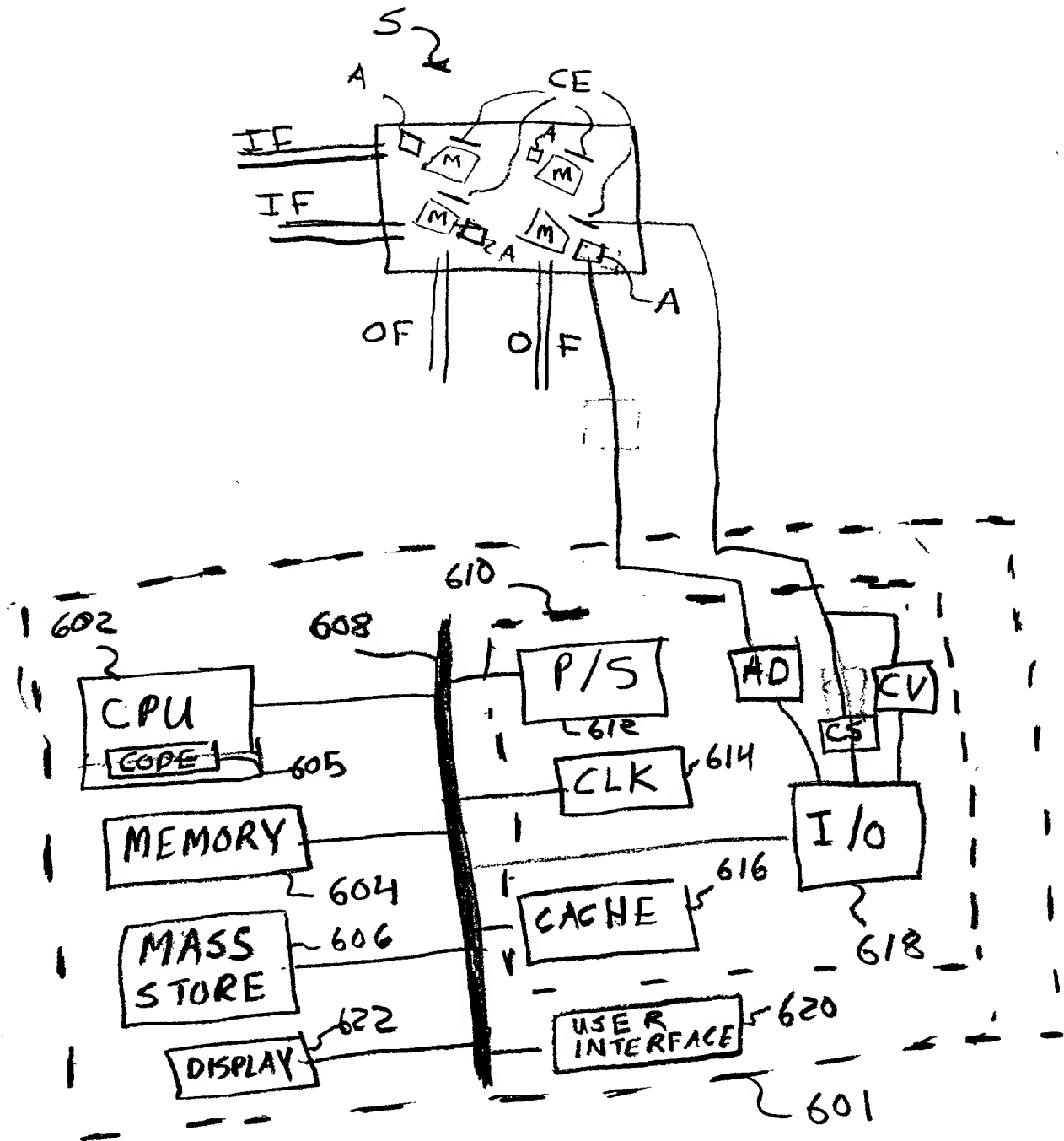


Fig. 6.

Declaration for Patent Application and Power of Attorney

As a below named inventor, I hereby declare that my residence, post office address, and citizenship are as stated below next to my name, and that I believe I am the original, first and sole inventor (if only one is listed) or an original, first and joint inventor (if plural names are listed) of the subject matter which is claimed and for which a patent is sought on the invention described in the attached specification entitled **Capacitive Sensing Scheme for Digital Control State Detection in Optical Switches.**

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I have reviewed and understand the contents of the above-identified specification, including the claims, as amended by any amendment referred to above. I acknowledge the duty to disclose information which is material to the examination of this application in accordance with Title 37, Code of Federal Regulations, §1.56(a). I claim foreign priority benefits under Title 35, United States Code, §119 of any foreign application(s) for patent or inventor's certificate listed below and have also identified below any foreign application for patent or inventor's certificate having a filing date before that of the application on which priority is claimed.

PRIOR FOREIGN APPLICATION(S)

Country	Application Number	Date of Filing	Priority Claimed Under 35 U.S.C. §119
NONE			<input type="checkbox"/> Yes <input type="checkbox"/> No

I claim the benefit under Title 35, United States Code, §120 of any United States application(s) listed below and, insofar as the subject matter of each of the claims of this application is not disclosed in the prior United States application in the manner provided by the first paragraph of Title 35, United States Code, §112, I acknowledge the duty to disclose material information as defined in Title 37, Code of Federal Regulations, §1.56 which occurred between the filing date of the prior application and the national or PCT international filing date of this application.

PRIOR U. S. APPLICATION(S)

Application No.	Filing Date	Status			
60/196,055	April 10, 2000	<input checked="" type="checkbox"/> Provisional	<input type="checkbox"/> Patented	<input type="checkbox"/> Pending	<input type="checkbox"/> Regular

I hereby appoint Thomas J. McFarlane, Reg. No. 39,299, Marek Alboszta, Reg. No. 39,894, Joshua D. Isenberg, Reg. No., 41,088, Rena Kaminsky, Reg. No. 46,818 as my agents with full power of substitution to prosecute this application and transact all business in the United States Patent and Trademark Office connected therewith. Direct all correspondence to:

Joshua D. Isenberg
 45 Cabot Ave., Suite 110
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 fax: (408) 260-7301

The attorney docket number for this case is: **ONX-110.**

I declare that all statements made herein of my own knowledge are true and that all statements made on information and belief are believed to be true; and further that these statements were made with the knowledge that willful false statements and the like so made are punishable by fine or Declaration, page 1 of 1

imprisonment, or both under Title 18, §1001 of the United States Code, and that such willful false statements may jeopardize the validity of the application or any patent issued thereon.

INVENTOR SIGNATURE(S)

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Date

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Date

MENG-HSIUNG KIANG

Date

KAM-YIN LAU

Date

TIMOTHY E. BEERLING

Date

DECLARATION OF INVENTORS

POWER OF ATTORNEY BY ASSIGNEE

The undersigned assignee of the entire interest in the attached application for Letters Patent for the invention entitled:

Capacitive Sensing Scheme for Digital Control State Detection in Optical Switches

by virtue of Assignment recorded concurrently herewith hereby appoints Thomas J. McFarlane, Reg. No. 39,299, Marek Alboszta, Reg. No. 39,894, Joshua D. Isenberg Reg. No. 41,088, Rena Kaminsky Reg. No. 46,818 as its agents to prosecute the attached application and to transact all business in the Patent and Trademark Office connected therewith, said appointment to be to the exclusion of the inventor(s) and their attorney(s) in accordance with the provisions of Rule 32 of the Patent Office Rules of Practice.

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I am duly authorized to sign this instrument on behalf of assignee corporation. I hereby declare that, to the best of my knowledge and belief, title is in the assignee herein, and I affirm review of the Assignment document concurrently submitted and believe that the attached application has been assigned to assignee herein and that assignee therefore has the right to make this Power of Attorney and Exclusion of Inventor(s).

I declare that all statements made herein of my own knowledge are true and that all statements made on information and belief are believed to be true; and further, that these statements were made with the knowledge that willful false statements and the like so made are punishable by fine or imprisonment, or both, under Section 1001 of Title 18 of the United States Code and that such willful false statements may jeopardize the validity of the application or any patent issued thereon.

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Official Authorized to Act on Behalf of Assignee:

Signature: _____

Name: _____

Title: _____

Date